Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/613,057	ZIEROLF, MICHAEL LEE	
Examiner	Art Unit	
Christopher P. Schwartz	3683	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE EXMR	
Search Updated	6/26/2005	
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